

Title (en)

Low voltage flash EEPROM X-cell using Fowler-Nordheim tunneling.

Title (de)

Niederspannungs-Flash-EEPROM-X-Zelle mit Fowler-Nordheim-Tunneling.

Title (fr)

Flash EEPROM cellule X à basse tension utilisant Fowler-Nordheim tunneling.

Publication

EP 0647947 A3 19981014 (EN)

Application

EP 94307419 A 19941010

Priority

- US 13581393 A 19931012
- US 13569593 A 19931012

Abstract (en)

[origin: EP0647947A2] A low voltage flash EEPROM X-Cell includes an array of memory cell transistors (24) that constitute asymmetric floating gate memory cells wherein programming is achieved on only one side of the memory cells (24). The programming side of each of the memory cells (24) is connected to one of a plurality of Column Lines (28) at nodes (30). Each node (30) shares the programming side of two of the memory cells (24) and the non-programming side of two of the memory cells (24). The control gates of each of the memory cells (24) are connected to Word Lines (26) associated with rows of the array. To Flash Write all of the memory cells (24), the Column Lines (38) are connected to a negative medium voltage and the row lines (26) are connected to a positive medium voltage. To selectively erase one of the memory cells (24), the Column Line (28) associated with the programing side of the select memory cell transistor is connected to a positive medium voltage and the associated line (26) is connected to a positive Read voltage. The remaining Word Lines are connected to a negative Read voltage and the remaining Column Lines (28) are connected to a zero volt level. <IMAGE>

IPC 1-7

G11C 16/04; H01L 27/115; G11C 16/06

IPC 8 full level

G11C 17/00 (2006.01); G11C 16/04 (2006.01); G11C 16/08 (2006.01); H01L 21/8247 (2006.01); H01L 27/115 (2006.01)

CPC (source: EP)

G11C 16/0416 (2013.01); G11C 16/08 (2013.01); H10B 69/00 (2023.02)

Citation (search report)

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Designated contracting state (EPC)

DE FR GB IT NL

DOCDB simple family (publication)

EP 0647947 A2 19950412; EP 0647947 A3 19981014; EP 0647947 B1 20030806; DE 69433001 D1 20030911; DE 69433001 T2 20040617; JP 2006128707 A 20060518; JP H07249293 A 19950926

DOCDB simple family (application)

EP 94307419 A 19941010; DE 69433001 T 19941010; JP 2005330231 A 20051115; JP 24586594 A 19941012